# Power MOSFET 3 Amps, 30 Volts

# P-Channel SO-8, FETKY™

The FETKY product family incorporates low R<sub>DS(on)</sub>, MOSFETs packaged with industry leading, low forward drop, low leakage Schottky Barrier rectifiers to offer high efficiency components in a space saving configuration. Independent pinouts for MOSFET and Schottky die allow the flexibility to use a single component for switching and rectification functions in a wide variety of applications such as Buck Converter, Buck–Boost, Synchronous Rectification, Low Voltage Motor Control, and Load Management in Battery Packs, Chargers, Cell Phones and other Portable Products.

- Power MOSFET with Low V<sub>F</sub>, Low I<sub>R</sub> Schottky Rectifier
- Lower Component Placement and Inventory Costs along with Board Space Savings
- R2 Suffix for Tape and Reel (2500 units/13" reel)
- Mounting Information for SO-8 Package Provided
- IDSS Specified at Elevated Temperature
- Applications Information Provided
- Marking: 3P303

# **MOSFET MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (Notes 1. & 2.)

	•		
Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	30	Vdc
Drain-to-Gate Voltage (R <sub>GS</sub> = 1.0 MΩ)	VDGR	30	Vdc
Gate-to-Source Voltage - Continuous	VGS	±20	Vdc
Drain Current  - Continuous @ $T_A = 25^{\circ}C$ - Continuous @ $T_A = 100^{\circ}C$ - Single Pulse (tp $\leq 10 \mu s$ )	I <sub>D</sub>	3.5 2.25 12	Adc Apk
Total Power Dissipation @ T <sub>A</sub> = 25°C (Note 3.)	PD	2.0	Watts
Single Pulse Drain–to–Source Avalanche Energy – STARTING T $_{\rm J}$ = 25°C V $_{\rm DD}$ = 30 Vdc, V $_{\rm GS}$ = 10 Vdc, V $_{\rm DS}$ = 20 Vdc, I $_{\rm L}$ = 9.0 Apk, L = 10 mH, R $_{\rm G}$ = 25 $\Omega$	E <sub>AS</sub>	375	mJ

- 1. Negative sign for P-channel device omitted for clarity.
- 2. Pulse Test: Pulse Width  $\leq$  250  $\mu s,$  Duty Cycle  $\leq$  2.0%.
- Mounted on 2" square FR4 board (1" sq. 2 oz. Cu 0.06" thick single sided), 10 sec. max.

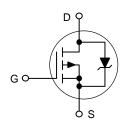


## ON Semiconductor™

http://onsemi.com

3 AMPERES 30 VOLTS RDS(on) = 100 m $\Omega$ VF = 0.42 Volts

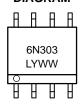
#### P-Channel



#### MARKING DIAGRAM

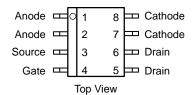


SO-8 CASE 751 STYLE 18



L = Location Code Y = Year WW = Work Week

#### **PIN ASSIGNMENT**



# ORDERING INFORMATION

Device	Package	Shipping
MMDFS3P303R2	SO–8	2500 Tape & Reel

#### SCHOTTKY RECTIFIER MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Peak Repetitive Reverse Voltage DC Blocking Voltage	V <sub>RRM</sub> V <sub>R</sub>	30	Volts
Average Forward Current (Note 3.) (Rated V <sub>R</sub> ) T <sub>A</sub> = 100°C	IO	3.0	Amps
Peak Repetitive Forward Current (Note 3.) (Rated V <sub>R</sub> , Square Wave, 20 kHz) T <sub>A</sub> = 105°C	I <sub>frm</sub>	6.0	Amps
Non-Repetitive Peak Surge Current (Surge applied at rated load conditions, halfwave, single phase, 60 Hz)	I <sub>fsm</sub>	30	Amps

#### THERMAL CHARACTERISTICS - SCHOTTKY AND MOSFET

Thermal Resistance – Junction–to–Ambient (Note 4.) – MOSFET	$R_{\theta JA}$	201	°C/W
Thermal Resistance – Junction–to–Ambient (Note 5.) – MOSFET	$R_{ heta JA}$	105	
Thermal Resistance – Junction–to–Ambient (Note 3.) – MOSFET	$R_{\theta JA}$	62.5	
Thermal Resistance – Junction–to–Ambient (Note 4.) – Schottky	$R_{ heta JA}$	197	
Thermal Resistance – Junction–to–Ambient (Note 5.) – Schottky	$R_{ heta JA}$	97	
Thermal Resistance – Junction–to–Ambient (Note 3.) – Schottky	$R_{ heta JA}$	62.5	
Operating and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

- 3. Mounted on 2" square FR4 board (1" sq. 2 oz. Cu 0.06" thick single sided), 10 sec. max.
- 4. Mounted with minimum recommended pad size, PC Board FR4.
- 5. Mounted on 2" square FR4 board (1" sq. 2 oz. Cu 0.06" thick single sided), Steady State.

#### **MOSFET ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (Notes 1. & 6.)

Characteristics			Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
, ,	S = 0 Vdc, I <sub>D</sub> = 0.25 mA) sperature Coefficient (Positive)	V(BR)DSS	30 -	- 27	-	Vdc mV/°C	
Zero Gate Drain Current $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 30 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 125^{\circ}\text{C})$			-		1.0 10	μAdc	
Gate Body Leakage Current	$(V_{GS} = \pm 20 \text{ Vdc}, V_{DS} = 0)$	IGSS	_	_	100	nAdc	
ON CHARACTERISTICS (Note 6.)		_					
Gate Threshold Voltage (V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 0.25 mA) Temperature Coefficient (Negative)		VGS(th)	1.0 -	1.7 3.5	_ _	Vdc mV/°C	
Static Drain-Source Resistance	R <sub>DS(on)</sub>	-	0.085 0.130	0.100 0.160	Ω		
Forward Transconductance (VDS	; = 15 Vdc, I <sub>D</sub> = 3.5 Adc)	9FS	_	5.0	-	mhos	
DYNAMIC CHARACTERISTICS		_					
Input Capacitance		C <sub>iss</sub>	_	405	-	pF	
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, $ f = 1.0 MHz)	C <sub>oss</sub>	_	200	-		
Reverse Transfer Capacitance		C <sub>rss</sub>	_	55	-		
SWITCHING CHARACTERISTICS	(Note 7.)						
Turn-On Delay Time		t <sub>d</sub> (on)	t <sub>d(on)</sub> – 1	12.5	25	ns	
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_D = 2.0 \text{ Adc},$	t <sub>r</sub>	_	16	30		
Turn-Off Delay Time	$V_{GS} = 10 \text{ Vdc},$ $R_{G} = 6.0 \Omega)$	td(off)	1	50	90		
Fall Time	1	t <sub>f</sub>	_	35	65		

- 1. Negative signs for P–Channel device omitted for clarity.
- 6. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2%.
- 7. Switching characteristics are independent of operating junction temperature.

## $\textbf{MOSFET ELECTRICAL CHARACTERISTICS - continued} \ (T_J = 25^{\circ}\text{C unless otherwise noted}) \ (\text{Notes 1. \& 6.})$

Characteristics			Min	Тур	Max	Unit		
SWITCHING CHARACTERISTICS – continued (Note 7.)								
Turn-On Delay Time		<sup>t</sup> d(on)	-	19	-	ns		
Rise Time	$(V_{DD} = 20 \text{ Vdc}, I_{D} = 2.0 \text{ Adc},$	t <sub>r</sub>	-	36	-			
Turn-Off Delay Time	$V_{GS} = 4.5 \text{ Vdc},$ $R_{G} = 6.0 \Omega)$	td(off)	-	27	-			
Fall Time		tf	_	31	-			
Gate Charge		Q <sub>T</sub>	_	14	25	nC		
	(V <sub>DS</sub> = 20 Vdc, I <sub>D</sub> = 3.5 Adc, V <sub>GS</sub> = 10 Vdc)	Q <sub>1</sub>	-	1.8	-			
		Q <sub>2</sub>	-	4.5	-			
		Q <sub>3</sub>	-	2.85 –	-			
DRAIN SOURCE DIODE CHARAC	TERISTICS							
Forward On-Voltage (Note 6.)	(I <sub>S</sub> = 1.7 Adc, V <sub>GS</sub> = 0 Vdc)	V <sub>SD</sub>	_	0.9	1.2	V		
Reverse Recovery Time		t <sub>rr</sub>	_	26.6	-	ns		
	0/ 0// 254	ta	ta – 18.8 –	-				
	$(V_{GS} = 0 \text{ V, } I_{S} = 3.5 \text{ A,}$ $dIS/dt = 100 \text{ A/}\mu\text{s})$	t <sub>b</sub>	_	7.8	-			
Reverse Recovery Stored Charge		Q <sub>RR</sub>	_	0.03	-	μС		

# 

Maximum Instantaneous Forward Voltage (Note 6.)	VF	T <sub>J</sub> = 25°C	T <sub>J</sub> = 125°C	Volts
I <sub>F</sub> = 100 mAdc I <sub>F</sub> = 3.0 Adc I <sub>F</sub> = 6.0 Adc		0.28 0.42 0.50	0.13 0.33 0.45	
Maximum Instantaneous Reverse Current (Note 6.)		T <sub>J</sub> = 25°C	T <sub>J</sub> = 125°C	μΑ
V <sub>R</sub> = 30 V		250	-	
		_	25	mA
Maximum Voltage Rate of Change V <sub>R</sub> = 30 V	dV/dt	10,000		V/μs

Negative signs for P–Channel device omitted for clarity.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

<sup>7.</sup> Switching characteristics are independent of operating junction temperature.

#### TYPICAL FET ELECTRICAL CHARACTERISTICS

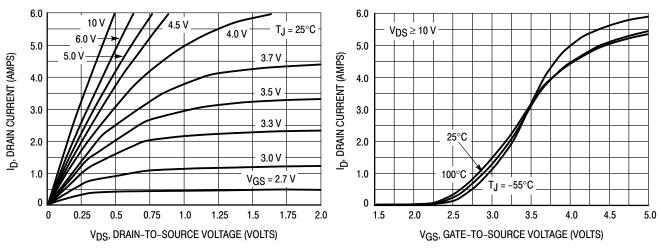


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

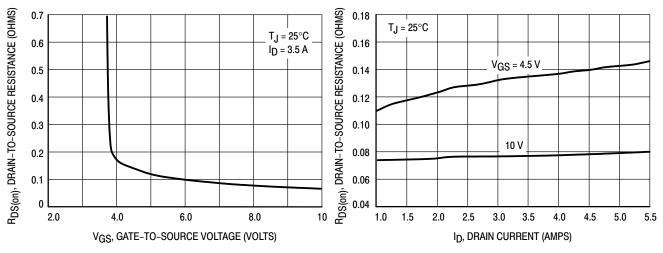


Figure 3. On–Resistance versus Gate–To–Source Voltage

Figure 4. On–Resistance versus Drain Current and Gate Voltage

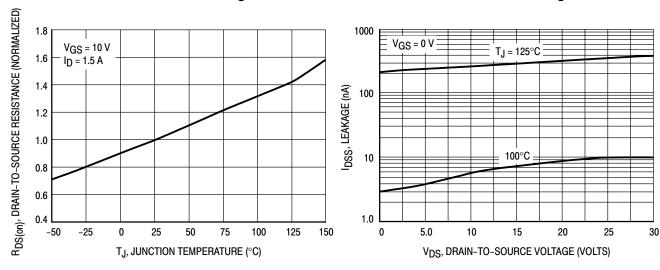
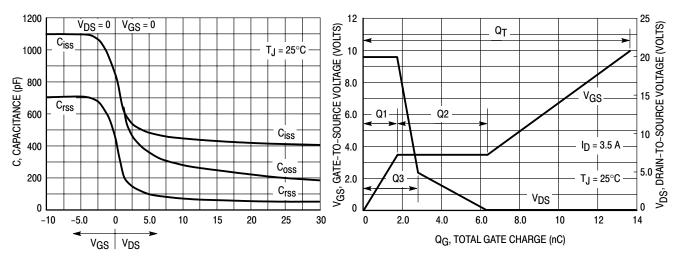


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-To-Source Leakage Current versus Voltage

#### TYPICAL FET ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate—To—Source and Drain—To—Source Voltage versus Total Charge

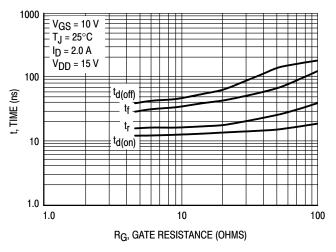


Figure 9. Resistive Switching Time Variation versus Gate Resistance

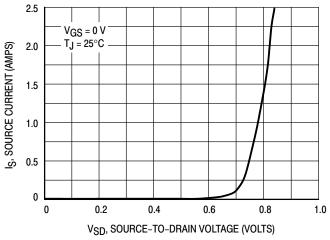


Figure 10. Diode Forward Voltage versus Current

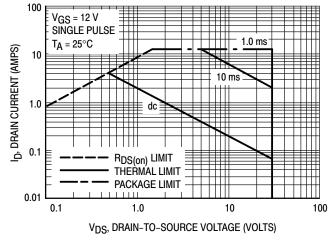


Figure 11. Maximum Rated Forward Biased Safe Operating Area

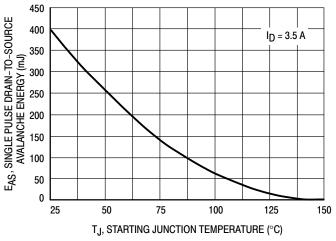


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

#### TYPICAL FET ELECTRICAL CHARACTERISTICS

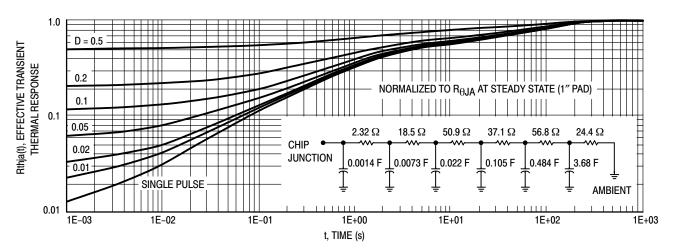


Figure 13. FET Thermal Response

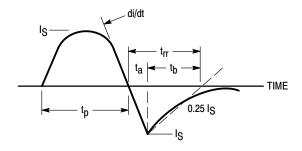


Figure 14. Diode Reverse Recovery Waveform

#### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

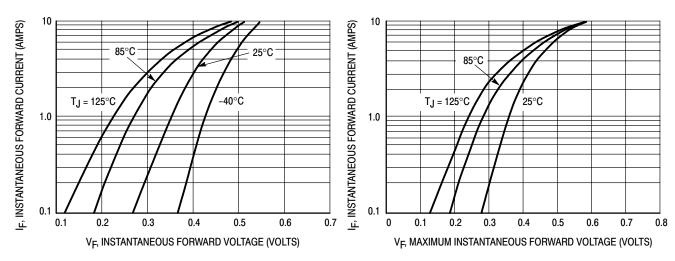
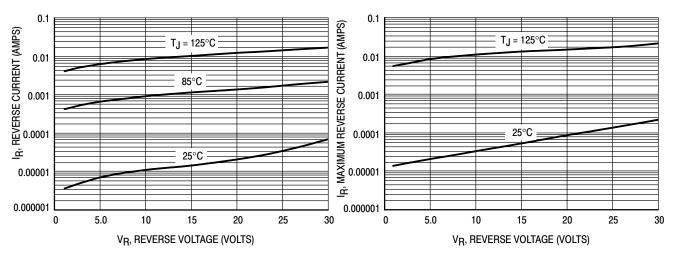


Figure 15. Typical Forward Voltage

Figure 16. Maximum Forward Voltage

#### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS



**Figure 17. Typical Reverse Current** 

Figure 18. Maximum Reverse Current

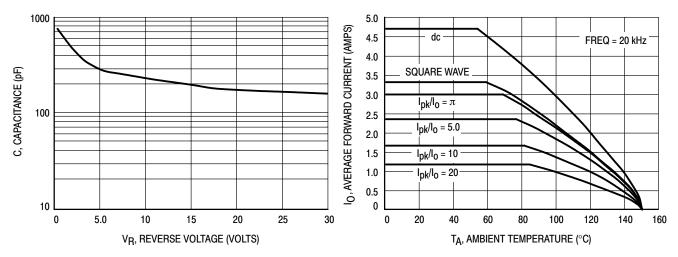


Figure 19. Typical Capacitance

Figure 20. Current Derating

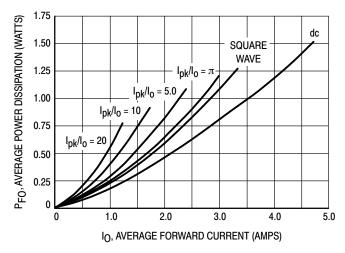


Figure 21. Forward Power Dissipation

#### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

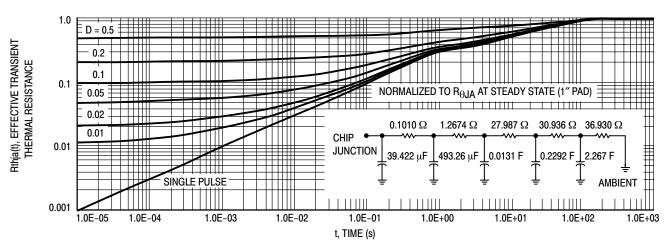
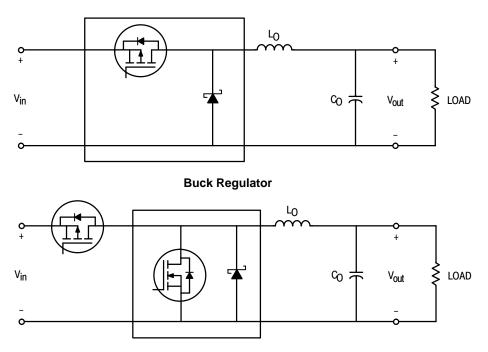


Figure 22. Schottky Thermal Response

#### **TYPICAL APPLICATIONS**

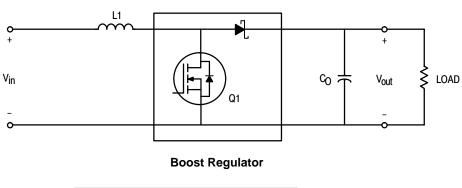
#### STEP DOWN SWITCHING REGULATORS

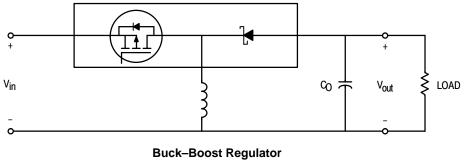


**Synchronous Buck Regulator** 

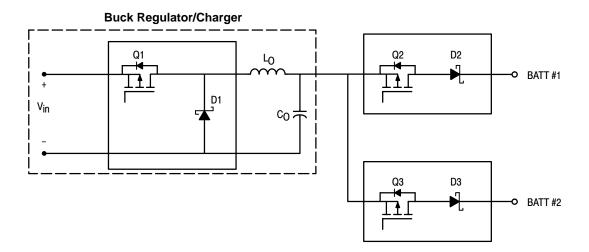
#### **TYPICAL APPLICATIONS**

#### STEP UP SWITCHING REGULATORS



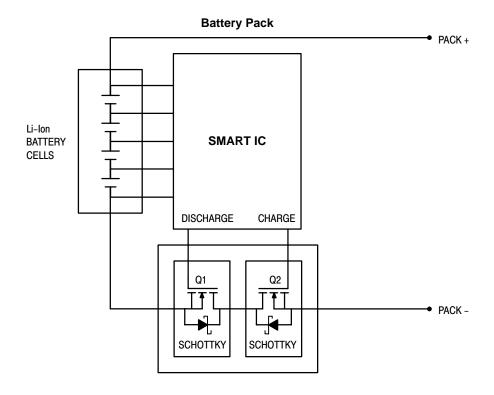


#### **MULTIPLE BATTERY CHARGERS**



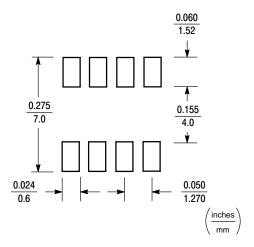
#### **TYPICAL APPLICATIONS**

#### Li-lon BATTERY PACK APPLICATIONS



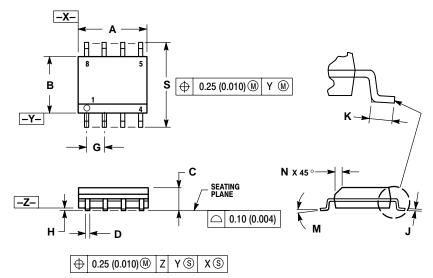
- Applicable in battery packs which require a high current level.
- During charge cycle Q2 is on and Q1 is off. Schottky can reduce power loss during fast charge.
- During discharge Q1 is on and Q2 is off. Again, Schottky can reduce power dissipation.
- Under normal operation, both transistors are on.

#### **SO-8 FOOTPRINT**



#### **PACKAGE DIMENSIONS**

SO-8 CASE 751-07 ISSUE V





- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- PROTRUSION.

  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.

  5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27	7 BSC	0.05	0 BSC	
Н	0.10	0.25	0.004	0.010	
7	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
M	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0 244	

STYLE 18:
PIN 1. ANODE
2. ANODE
3. SOURCE

- 4. GATE

- 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE

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